

QA Monitor Readiness for Pass1 of RGA Outbending Data

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First Experiment Meeting
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QA Monitoring Timelines

Timelines Link

<https://clas12mon.jlab.org/rga/pass1/qa/tlsummary/>

subsystem	variables	link
(dataset)		
INBENDING1	<ul style="list-style-type: none">• beam_spin_asymmetry• defined_helicity_fraction• electron_FT_yield_normalized_values• electron_trigger_yield_normalized_values• faraday_cup_charge• live_time• pim_kinematics_means• pim_kinematics_stddevs• pip_kinematics_means• pip_kinematics_stddevs• q2_W_x_y_means• q2_W_x_y_stddevs• relative_luminosity	timelines
INBENDING1_QA	<ul style="list-style-type: none">• SectorLoss• Any_Defect• TerminalOutlier• LiveTimeGT1• MarginalOutlier• TotalOutlier• Misc	timelines
INBENDING1_SUPPLEMENTAL	<ul style="list-style-type: none">• electron_FT_yield_QA_Automatic_Result• electron_trigger_yield_QA_Automatic_Result• electron_FT_yield_QA_epoch_view• electron_FT_yield_stddev• electron_FT_yield_values• electron_trigger_yield_QA_epoch_view• electron_trigger_yield_stddev• electron_trigger_yield_values• faraday_cup_stddev• helicity_sinPhi	timelines

Monitoring timelines

- these are used to perform QA

QA timelines

- lists files with “defect bits”
- this is the QA result

Supplemental timelines

- extra / expert QA timelines

QA Monitoring Timelines

Timelines Link

<https://clas12mon.jlab.org/rga/pass1/qa/tlsummary/>

Listed data sets:

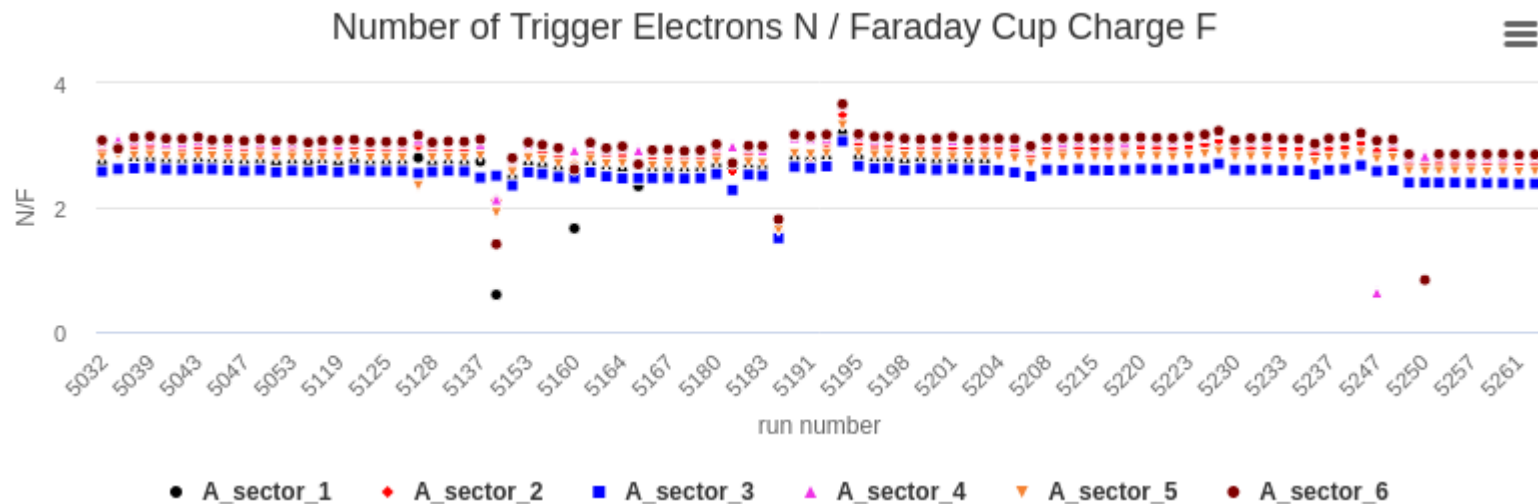
- Inbending1: runs 5032 – 5262
 - Inbending2: runs 5300 – 5419
 - Outbending data: need DST files before QA can start
- } to be merged into one set “inbending”

To showcase the features of the QA monitor, these slides will focus on the **Inbending1** dataset

The QA is divided into two parts:

- automatic QA: based on electron yield and FCup charge
- manual QA: based on automatic QA result, and inspection of additional timelines

Normalized Electron Trigger Yield



- Number of electron triggers (N) normalized by Faraday Cup charge (F)
- Outliers are automatically identified by IQR method; IQR is calculated in regions of relatively constant N/F called “epochs” (see backup)
- The livetime is also monitored as part of the automatic QA

Defect Bits

- Various criteria are checked, and *defect bits* are assigned to a file if any anomalies are found
- Different analyses have different levels of quality criteria, so the idea is to identify defects, and let the analyzer decide which runs are sufficient for their analysis

Defect Bit List:

0	TotalOutlier:	outlier N/F, but not terminal, marginal, or sector loss
1	TerminalOutlier:	outlier N/F of first or last file of run, not marginal
2	MarginalOutlier:	marginal outlier N/F, within one stddev of cut line
3	SectorLoss:	N/F diminished within a sector for several consecutive files
4	LiveTimeGT1:	live time > 1
5	Misc:	miscellaneous defect, documented as comment

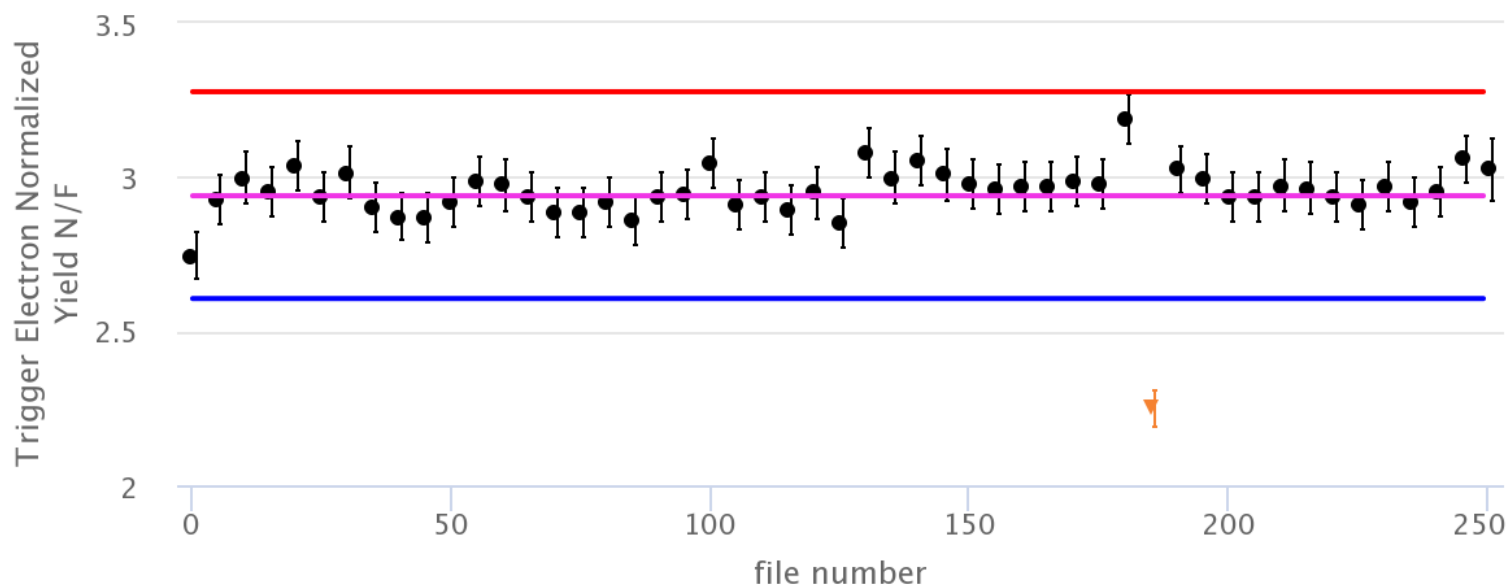
For bits 0-3, only 1 can be assigned to a file

The next few slides show examples of each of these

- plots of N/F vs. file number, for a particular run and sector
- files with the defect are drawn as red points
- cut lines, as well as the epoch's median, are drawn as well

Bit 0: TotalOutlier

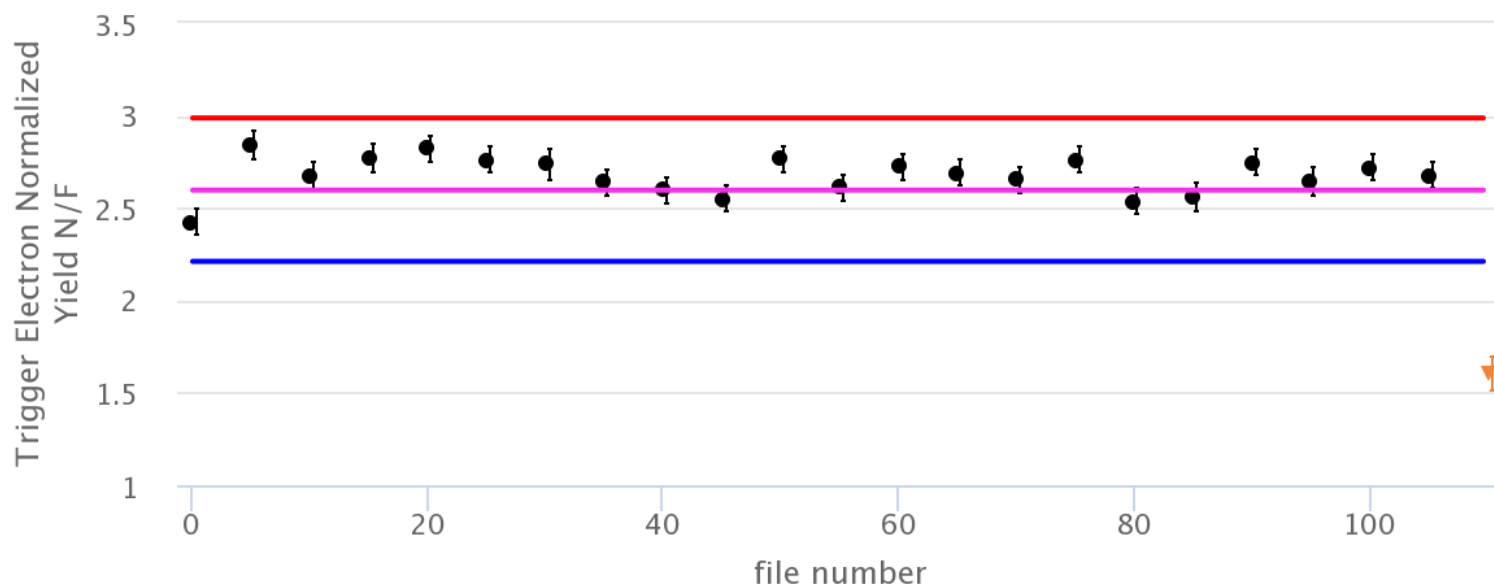
RUN 5211: Trigger Electron Normalized Yield N/F vs. file number --
Sector 2



Identified by Automatic QA

Bit 1: TerminalOutlier

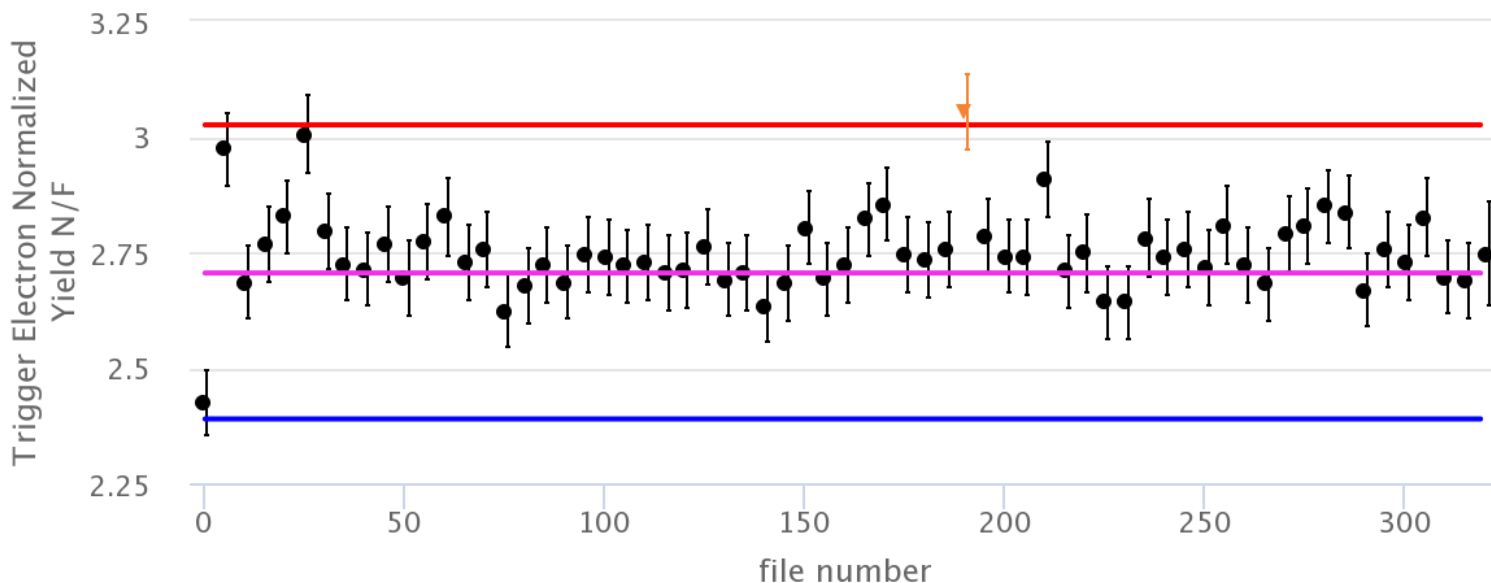
RUN 5158: Trigger Electron Normalized Yield N/F vs. file number --
Sector 1



Identified by Automatic QA

Bit 2: MarginalOutlier

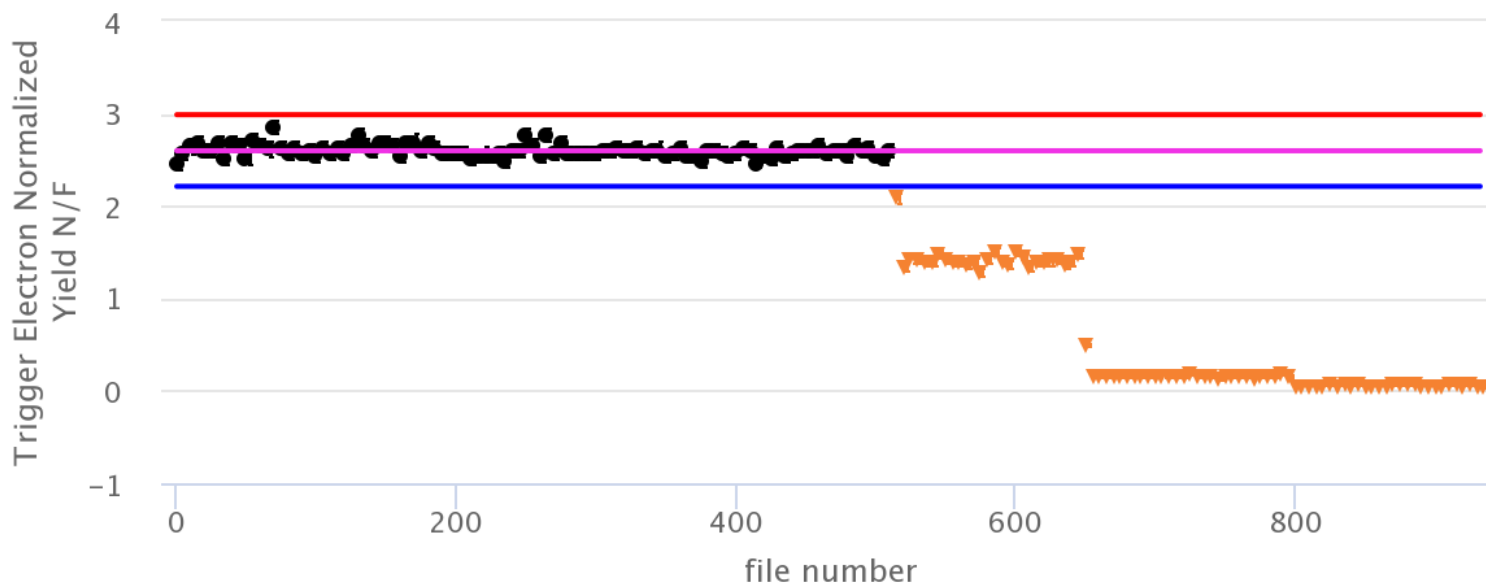
RUN 5039: Trigger Electron Normalized Yield N/F vs. file number --
Sector 1



Identified by Automatic QA

Bit 3: SectorLoss

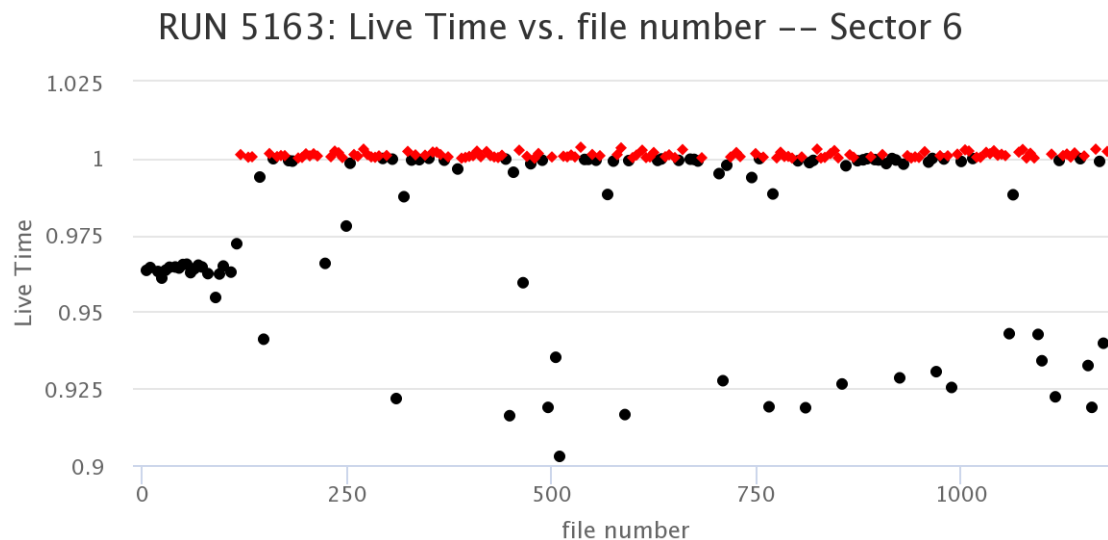
RUN 5160: Trigger Electron Normalized Yield N/F vs. file number --
Sector 1



Identified as Outliers in Automatic QA

Manual QA is used to change the bit to SectorLoss

Bit 4: LiveTimeGT1



Identified by Automatic QA

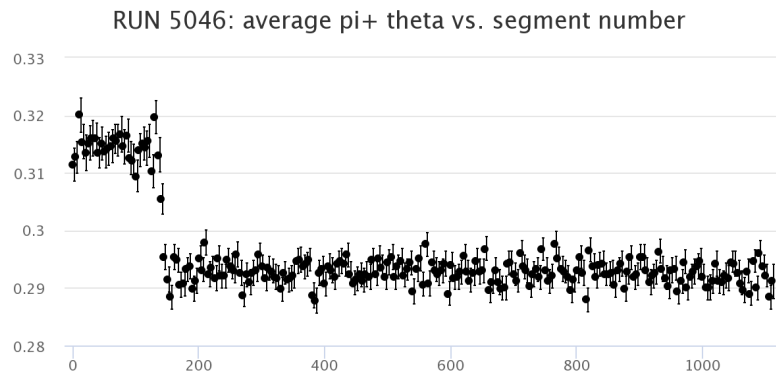
Note: this livetime calculation might not be correct!

- based on ratio of gated to ungated FC charge
- ungated FC charge has some issues in inbending2
- low-lumi runs' livetime is inconsistent

Need to crosscheck with other livetime tables

Bit 5: Misc

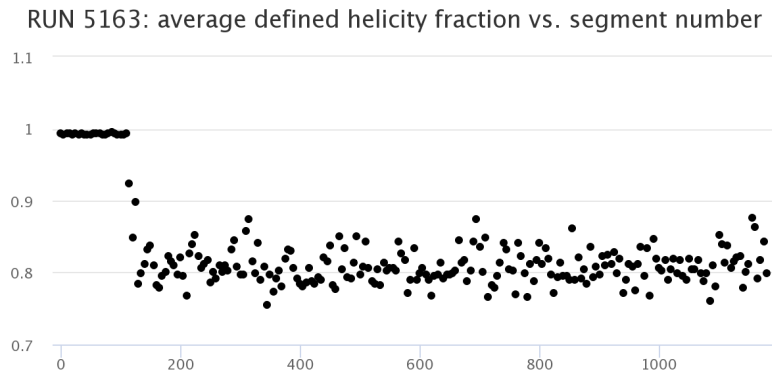
Jump in pion θ



- Plots show some examples
- A comment is stored in the QA database* if this bit is used

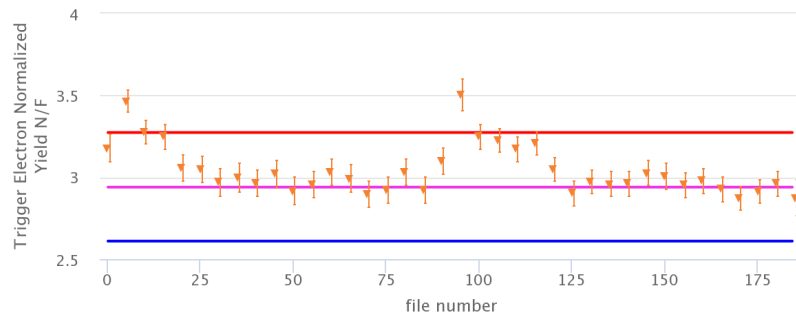
* currently just a JSON file

Low fraction of events with defined helicity



Unstable beam

RUN 5229: Trigger Electron Normalized Yield N/F vs. file number -- Sector 1



Overall Quality

■ **Inbending1: runs 5032 – 5262**

- Files with no defects: **76%**
- Files with defect = Misc: **23%**
- Files with livetime>1: **6%**

■ **Inbending2: runs 5300 – 5419**

- Files with no defects: **87%**
- Files with defect = Misc: **12%**
- Files with livetime>1: **0.4%**

Caveats:

- Files with defect=Misc are not necessarily “bad”, but this flag should serve as a warning to the analyzer
- The livetime calculation may not be accurate

The QA “Database”

- QA results are currently stored in a JSON file
 - Accessors and modifiers are implemented, but could certainly be improved
 - Access file number via mapping event number to file number
- Software meeting discussion: include defect bit in the trains
 - Does not allow for access to QA comment
 - Not easy to update
- Still under discussion, but JSON file is a start

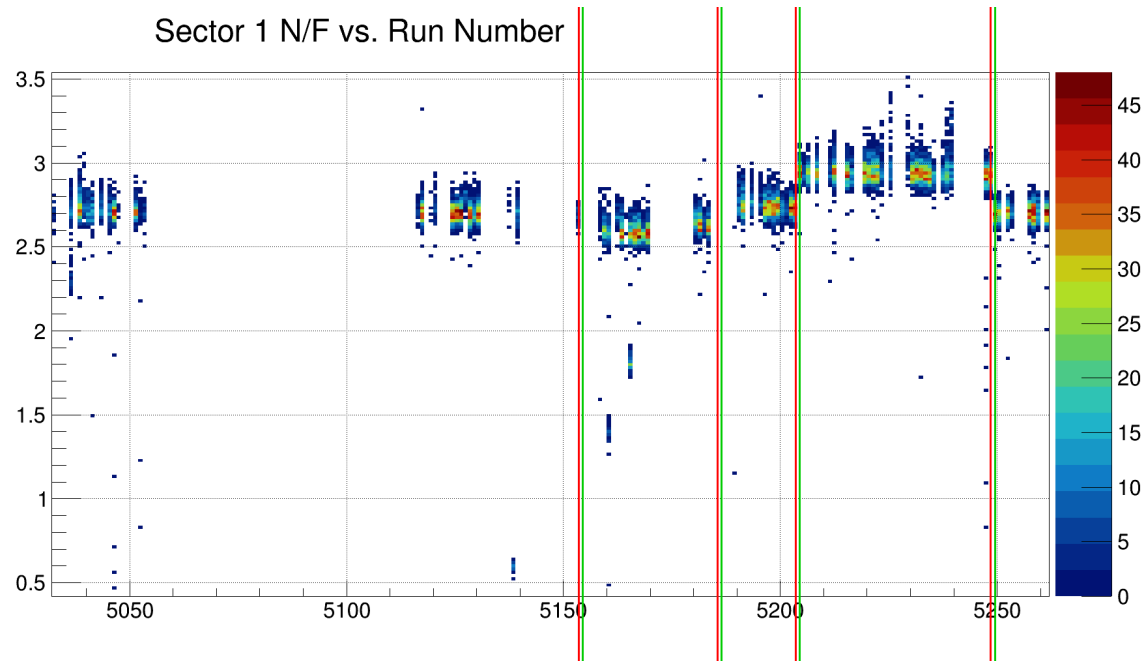
```
▶ 5323:      {...}
▶ 5324:      {...}
▼ 5325:
  ▼ 0:
    ▶ comment:      "torus at 60%, high trigg...to 30 nA during the run"
    defect:         33
    ▶ sectorDefects: {...}
  ▼ 5:
    ▶ comment:      "torus at 60%, high trigg...to 30 nA during the run"
    defect:         33
    ▶ sectorDefects: {...}
  ▼ 10:
    ▶ comment:      "torus at 60%, high trigg...to 30 nA during the run"
    defect:         33
    ▶ sectorDefects: {...}
  ▶ 15:      {...}
  ▶ 20:      {...}
  ▶ 25:      {...}
  ▶ 30:      {...}
```

Plans

- Add event number ranges to QA JSON file
- Decide how the QA information can be accessed by all analyzers
- Silvia is applying this software to RGB, and helping spot bugs in the code and in the documentation
- The software is ready to run on outbending data

BACKUP

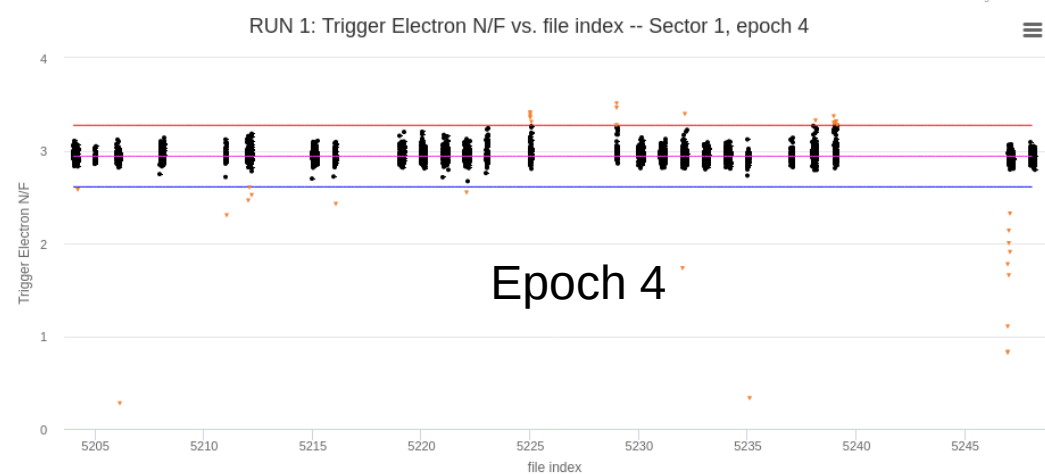
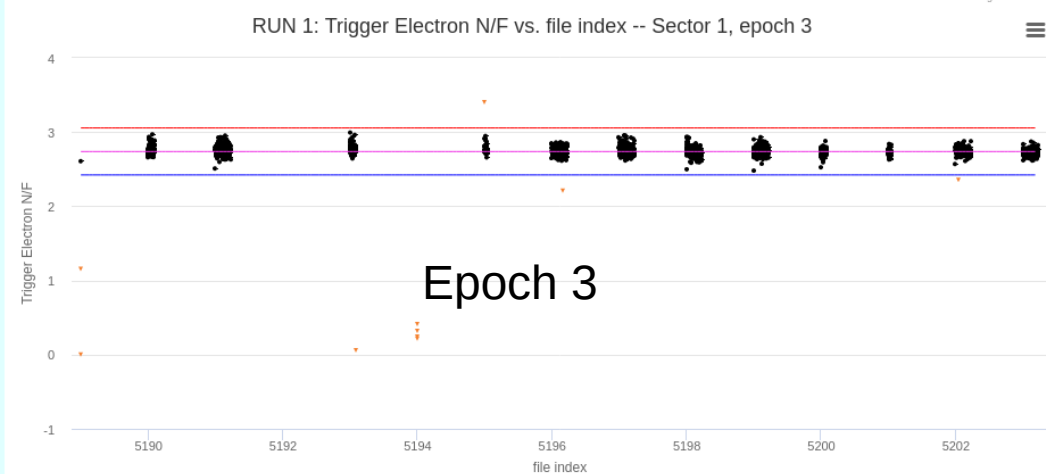
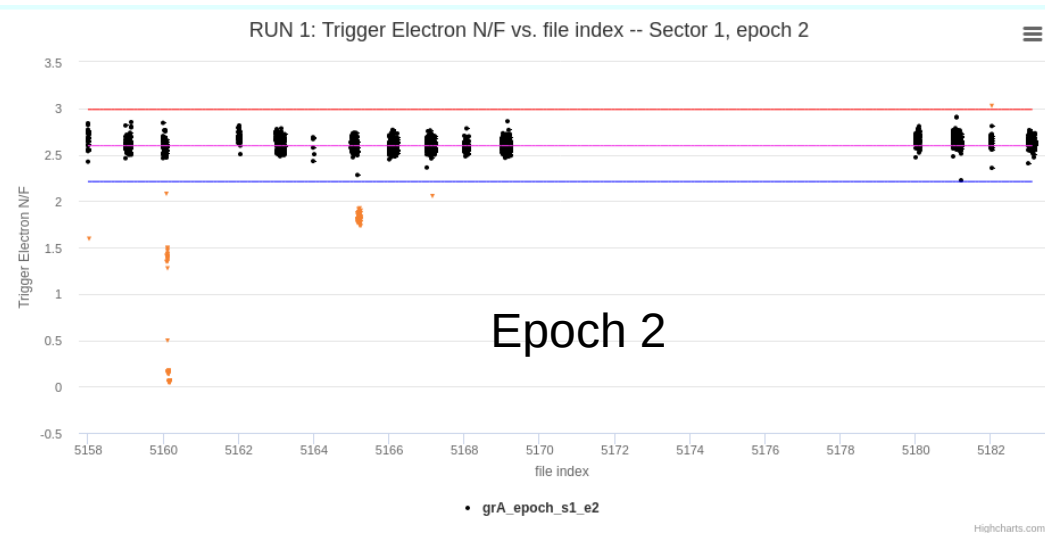
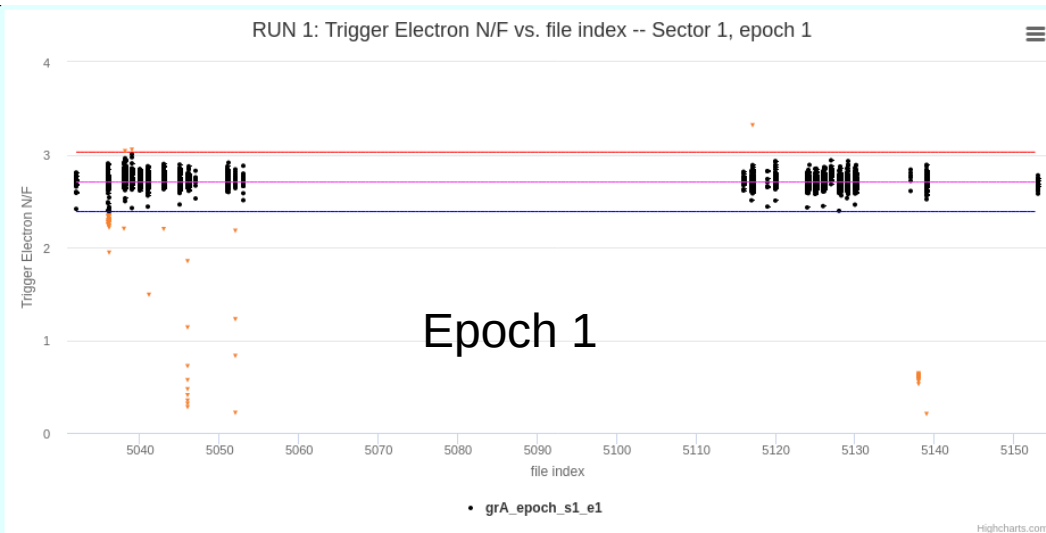
Epoch boundaries



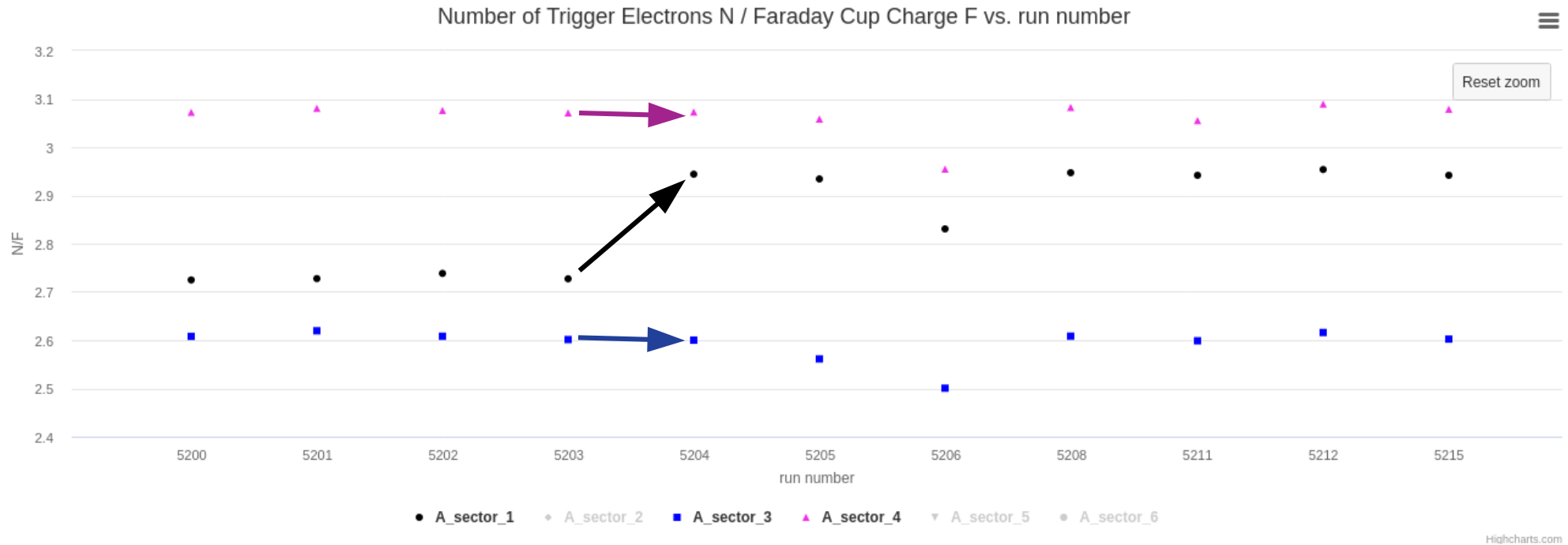
- Plot of Charge-normalized electron trigger yield “N/F” vs. Run Number
- QA cut lines are set with 4*IQR method, determined separately within each epoch
- Vertical lines represent epoch boundaries

Epoch boundaries

- N/F vs. Run Number, for Sector 1, Epochs 1-4
- These plots are used to tune epoch boundaries and width of cut lines



Epoch boundaries



- Sector 1 has a step between runs 5204 and 5205, relative to all other sectors
- An epoch boundary for the QA is drawn here, even though it is only needed for sector 1